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## Amendments To The Claims

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- A method for refining a length of a scan line, wherein said-scan-ice entracts at the 1. (original) line is produced from a facet of a scanning device, comprising the steps of:
  - (a) acquiring a plurality of scan line lengths produced from a facet;
  - (b) determining from said plurality of scan line lengths, an average scan line length for said facet; and
  - (c) determining from said average scan line length, a scan line length correction for said facet.
- 2. (original) The method of claim 1, wherein said facet is one of a plurality of facets on a rotating reflector, and wherein said method further comprises the step of obtaining a number from a cyclic counter to identify said facet and to associate said plurality of scan line lengths with said facet when determining said average scan line length.
- 3. (original) The method of claim 1, wherein said scanning device produces pixels at a dot imaging frequency, and wherein said plurality of scan line lengths is acquired from a counter that is clocked at a rate of less than 8 times said dot imaging frequency.
- A system for refining a length of a scan line, wherein said scan 4. (original) line is produced from a facet of a scanning device, comprising:
  - (a) means for acquiring a plurality of scan line lengths produced from a facet;
  - (b) means for determining from said plurality of scan line lengths, an average scan line length for said facet; and
  - (c) means for determining from said average scan line length, a scan line length correction for said facet.
- 5. (original) The system of claim 4, wherein said facet is one of a plurality of facets on a rotating reflector, and wherein said system further comprises a cyclic counter for providing a number for said facet to identify said facet and to associate said plurality of scan line lengths with said facet when determining said average

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scan line length.

- 6.அரைப்பாகி) The system of claim 4, wherein said scanning device producesள வ கூடிக்கு கண் pixels at a dot imaging frequency, and wherein said acquiring means comprises a consideration of the control of counter that is clocked at a rate of less than 8 times said dot imaging frequency.
- 7. (original) A storage medium that includes instructions for controlling a processor to execute a method for refining a length of a scan line, wherein said scan line is produced from a facet of a scanning device, said storage medium comprising:
  - (a) first instructions for controlling said processor to acquire a plurality of scan line lengths produced from a facet;
  - (b) second instructions for controlling said processor to determine from said plurality of scan line lengths, an average scan line length for said facet: and
  - (c) third instructions for controlling said processor to determine from said average scan line length, a scan line length correction for said facet.
- 8. (original) The storage medium of claim 7, wherein said facet is one of a plurality of facets on a rotating reflector, and wherein said storage medium comprises further instructions for controlling said processor to obtain a number from a cyclic counter to identify said facet and to associate said plurality of scan line lengths with said facet when determining said average scan line length.
- 9. (original) The storage medium of claim 7, wherein said scanning device produces pixels at a dot imaging frequency, and wherein said scan line length is acquired from a counter that is clocked at a rate of less than 8 times said dot imaging frequency.

10-30. (cancelled)